

# BUK545-100B-VB Datasheet N-Channel 100-V (D-S) MOSFET

| PRODUCT SUMMARY          |                                |                    |  |  |  |
|--------------------------|--------------------------------|--------------------|--|--|--|
| V <sub>(BR)DSS</sub> (V) | $R_{DS(on)}(\Omega)$           | I <sub>D</sub> (A) |  |  |  |
| 100                      | 0.127at V <sub>GS</sub> = 10 V | 18                 |  |  |  |

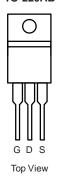
#### **FEATURES**

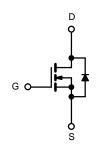
- Trench Power MOSFET
- 175 °C Junction Temperature
- Low Thermal Resistance Package
- 100 % R<sub>g</sub> Tested



## APPLICATIONSIsolated DC/DC Converters

### TO-220AB





N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS T <sub>C</sub> = 25 °C, unless otherwise noted |                                     |                                   |             |      |  |  |
|---|-------------------------------------|-----------------------------------|-------------|------|--|--|
| Parameter   |                                     | Symbol                            | Limit       | Unit |  |  |
| Drain-Source Voltage  | V <sub>DS</sub>                     | 100                               | V           |      |  |  |
| Gate-Source Voltage   |                                     | V <sub>GS</sub>                   | ± 20        |      |  |  |
| Continuous Drain Current (T <sub>.1</sub> = 175 °C)                     | T <sub>C</sub> = 25 °C              | 1-                                | 18          |      |  |  |
| Continuous Diain Current (1, = 175 °C)                                  | T <sub>C</sub> = 125 °C             | I <sub>D</sub>                    | 15          |      |  |  |
| Pulsed Drain Current  |                                     | I <sub>DM</sub>                   | 68          | A    |  |  |
| Avalanche Current   | L = 0.1 mH                          | I <sub>AS</sub>                   | 18          |      |  |  |
| Single Pulse Avalanche Energy <sup>b</sup>                              | L=0.11IIII                          | E <sub>AS</sub>                   | 200         | mJ   |  |  |
| Mariana Barra Biratianiah   | T <sub>C</sub> = 25 °C              | D D                               | 105         | 10/  |  |  |
| Maximum Power Dissipation <sup>b</sup>                                  | T <sub>A</sub> = 25 °C <sup>d</sup> | $ P_D$ $-$                        | 3.75        | W    |  |  |
| Operating Junction and Storage Temperature Ra                           | nge                                 | T <sub>J</sub> , T <sub>stg</sub> | - 55 to 175 | °C   |  |  |

| THERMAL RESISTANCE RATINGS |                                 |                   |       |      |  |  |
|----------------------------|---------------------------------|-------------------|-------|------|--|--|
| Parameter                  |                                 | Symbol            | Limit | Unit |  |  |
| Junction-to-Ambient        | PCB Mount (TO-263) <sup>d</sup> | R <sub>thJA</sub> | 40    | °C/W |  |  |
| Junction-to-Case (Drain)   |                                 | R <sub>thJC</sub> | 0.4   |      |  |  |

#### Notes:

- a. Package limited.
- b. Duty cycle  $\leq$  1 %.
- c. See SOA curve for voltage derating.
- d. When Mounted on 1" square PCB (FR-4 material).



| Parameter                                     | Symbol               | Test Conditions   | Min. | Тур.  | Max.  | Unit |  |
|---|----------------------|---|------|-------|-------|------|--|
| Static  |                      |   |      |       |       |      |  |
| Drain-Source Breakdown Voltage                | V <sub>(BR)DSS</sub> | $V_{DS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$                         | 100  |       |       | V    |  |
| Gate-Threshold Voltage                        | V <sub>GS(th)</sub>  | $V_{DS} = V_{GS}, I_D = 250 \mu A$                                      | 2    |       | 4     | V    |  |
| Gate-Body Leakage                             | I <sub>GSS</sub>     | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$                       |      |       | ± 100 | nA   |  |
|   |                      | V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V                          |      |       | 1     |      |  |
| Zero Gate Voltage Drain Current               | I <sub>DSS</sub>     | V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C |      |       | 50    | μΑ   |  |
|   |                      | V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 175 °C |      |       | 250   |      |  |
| On-State Drain Current <sup>a</sup>           | I <sub>D(on)</sub>   | $V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$                         | 120  |       |       | Α    |  |
|   |                      | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A                           |      | 0.127 |       | Ω    |  |
| Drain-Source On-State Resistance <sup>a</sup> | r <sub>DS(on)</sub>  | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A, T <sub>J</sub> = 125 °C  |      | 0.130 |       |      |  |
|   |                      | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A, T <sub>J</sub> = 175 °C  |      | 0.170 |       |      |  |
| Forward Transconductance <sup>a</sup>         | 9 <sub>fs</sub>      | V <sub>DS</sub> = 15 V, I <sub>D</sub> = 20 A                           | 25   |       |       | S    |  |
| Dynamic <sup>b</sup>                          |                      |   |      |       |       |      |  |
| Input Capacitance                             | C <sub>iss</sub>     | V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 25 V, f = 1 MHz                |      | 1300  |       | pF   |  |
| Output Capacitance                            | C <sub>oss</sub>     |   |      | 260   |       |      |  |
| Reverse Transfer Capacitance                  | C <sub>rss</sub>     |   |      | 110   |       |      |  |
| Total Gate Charge <sup>c</sup>                | $Q_g$                |   |      |       | 28    |      |  |
| Gate-Source Charge <sup>c</sup>               | $Q_{gs}$             | $V_{DS} = 100 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 65 \text{ A}$     |      |       | 4.8   | nC   |  |
| Gate-Drain Charge <sup>c</sup>                | $Q_{gd}$             |   |      |       | 15    |      |  |
| Gate Resistance                               | $R_g$                |   | 0.5  | 1.7   | 3.3   | Ω    |  |
| Turn-On Delay Time <sup>c</sup>               | t <sub>d(on)</sub>   |   |      | 8     |       |      |  |
| Rise Time <sup>c</sup>                        | t <sub>r</sub>       | $V_{DD} = 100 \text{ V}, R_{L} = 1.5 \Omega$                            |      | 120   |       | ns   |  |
| Turn-Off Delay Time <sup>c</sup>              | t <sub>d(off)</sub>  | $I_D \cong 65 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 2.5 \Omega$      |      | 25    |       |      |  |
| Fall Time <sup>c</sup>                        | t <sub>f</sub>       |   |      | 50    |       | 1    |  |
| Source-Drain Diode Ratings and Ch             | aracteristics 7      | √ <sub>C</sub> = 25 °C <sup>b</sup>                                     |      |       |       |      |  |
| Continuous Current                            | I <sub>S</sub>       |   |      | 18    |       | Α    |  |
| Pulsed Current                                | I <sub>SM</sub>      |   |      | 68    |       | A    |  |
| Forward Voltage <sup>a</sup>                  | $V_{SD}$             | I <sub>F</sub> = 65 A, V <sub>GS</sub> = 0 V                            |      | 1.0   | 1.5   | V    |  |
| Reverse Recovery Time                         | t <sub>rr</sub>      |   |      | 130   | 200   | ns   |  |
| Peak Reverse Recovery Current                 | I <sub>RM(REC)</sub> | I <sub>F</sub> = 50 A, di/dt = 100 A/μs                                 |      | 8     | 12    | Α    |  |
| Reverse Recovery Charge                       | Q <sub>rr</sub>      |   |      | 0.52  | 1.2   | иC   |  |

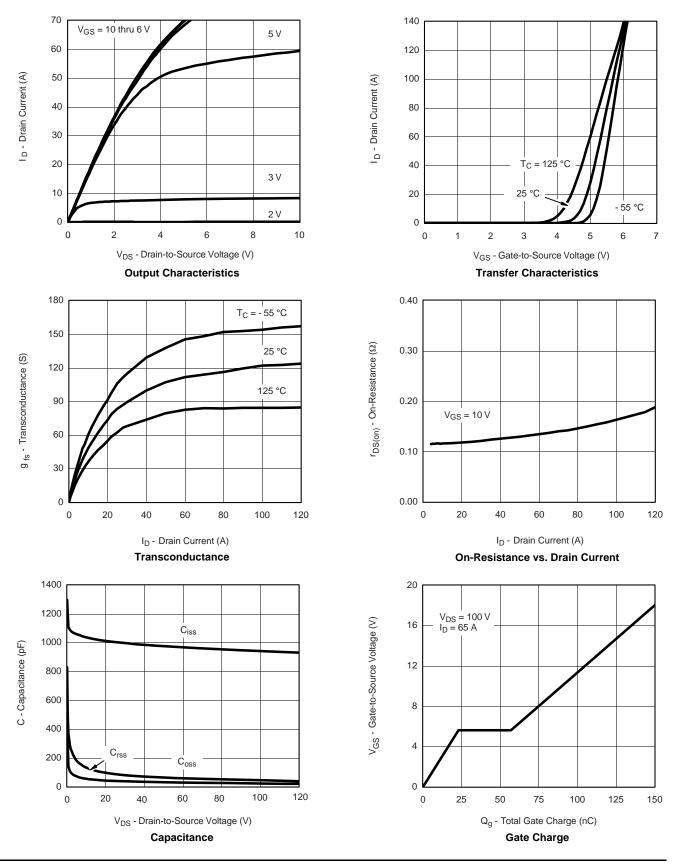
#### Notes

- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

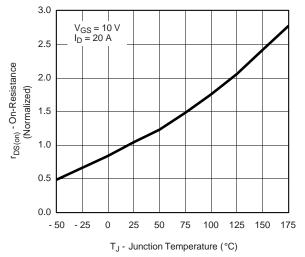


### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

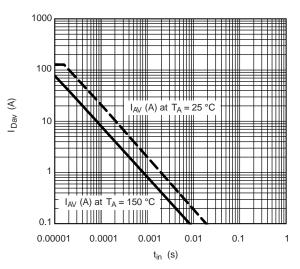




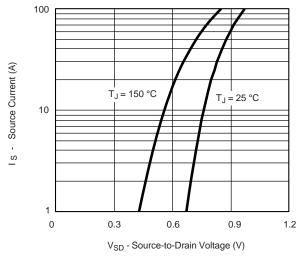
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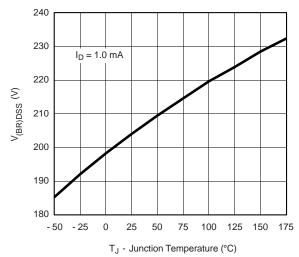
On-Resistance vs. Junction Temperature



Avalanche Current vs. Time



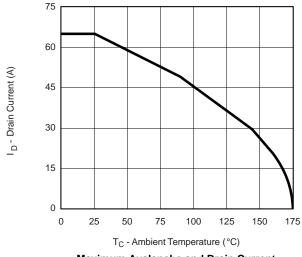
Source-Drain Diode Forward Voltage



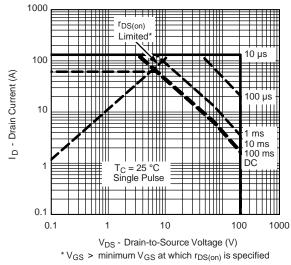
Drain Source Breakdown vs. Junction Temperature



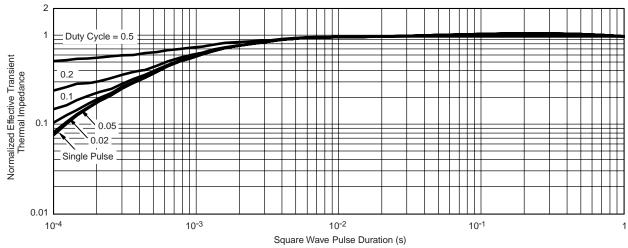
#### THERMAL RATINGS



Maximum Avalanche and Drain Current
vs. Case Temperature



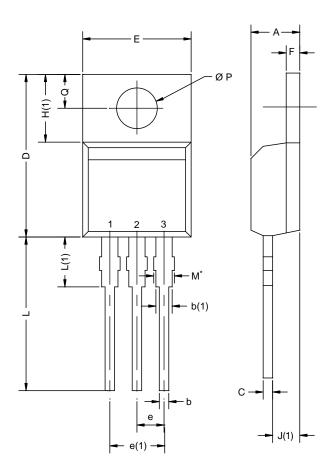
Safe Operating Area



Normalized Thermal Transient Impedance, Junction-to-Case



## **TO-220AB**



|  | MILLIM | IETERS | INCHES |       |  |  |
|--|--------|--------|--------|-------|--|--|
| DIM.   | MIN.   | MAX.   | MIN.   | MAX.  |  |  |
| Α  | 4.25   | 4.65   | 0.167  | 0.183 |  |  |
| b  | 0.69   | 1.01   | 0.027  | 0.040 |  |  |
| b(1)   | 1.20   | 1.73   | 0.047  | 0.068 |  |  |
| С  | 0.36   | 0.61   | 0.014  | 0.024 |  |  |
| D  | 14.85  | 15.49  | 0.585  | 0.610 |  |  |
| E  | 10.04  | 10.51  | 0.395  | 0.414 |  |  |
| е  | 2.41   | 2.67   | 0.095  | 0.105 |  |  |
| e(1)   | 4.88   | 5.28   | 0.192  | 0.208 |  |  |
| F  | 1.14   | 1.40   | 0.045  | 0.055 |  |  |
| H(1)   | 6.09   | 6.48   | 0.240  | 0.255 |  |  |
| J(1)   | 2.41   | 2.92   | 0.095  | 0.115 |  |  |
| L  | 13.35  | 14.02  | 0.526  | 0.552 |  |  |
| L(1)   | 3.32   | 3.82   | 0.131  | 0.150 |  |  |
| ØΡ   | 3.54   | 3.94   | 0.139  | 0.155 |  |  |
| Q  | 2.60   | 3.00   | 0.102  | 0.118 |  |  |
| ECN: X12-0208-Rev. N, 08-Oct-12<br>DWG: 5471 |        |        |        |       |  |  |

#### Notes

 $<sup>^{\</sup>star}$  M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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